

## Complementary 30-V (D-S) MOSFET

PRODUCT SUMMARY			
	V <sub>DS</sub> (V)	r <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)
P-Channel	-30	0.051 @ V <sub>GS</sub> = -10 V	-6.4
		0.075 @ V <sub>GS</sub> = -6 V	-5.3
N-Channel	30	0.035 @ V <sub>GS</sub> = 10 V	7.7
		0.050 @ V <sub>GS</sub> = 4.5 V	6.5

### FEATURES

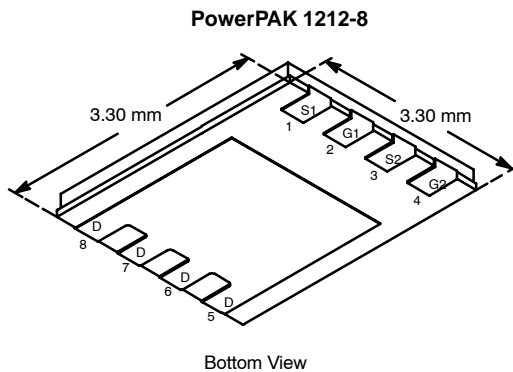
- TrenchFET® Power MOSFET
- New Low Thermal Resistance PowerPAK® Package with Low 1.07-mm Profile



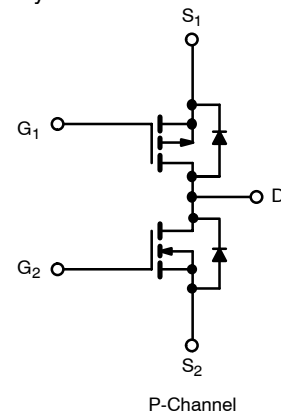
**RoHS**  
COMPLIANT

### APPLICATIONS

- Backlight Inverter
- DC/DC Converter
  - 4-Cell Battery



Ordering Information: Si7501DN-T1—E3 (Lead (Pb)-Free)



### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)

Parameter	Symbol	P-Channel		N-Channel		Unit	
		10 secs	Steady State	10 secs	Steady State		
Drain-Source Voltage	V <sub>DS</sub>	-30		30		V	
Gate-Source Voltage	V <sub>GS</sub>	±25		±20			
Continuous Drain Current (T <sub>J</sub> = 150°C) <sup>a</sup>	I <sub>D</sub>	T <sub>A</sub> = 25°C	-6.4	-4.5	7.7	5.4	A
		T <sub>A</sub> = 70°C	-5.1	-3.6	4.7	4.3	
Pulsed Drain Current	I <sub>DM</sub>	-25		25		W	
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	-2.6	-1.3	2.6	1.3		
Maximum Power Dissipation <sup>a</sup>	P <sub>D</sub>	T <sub>A</sub> = 25°C	3.1	1.6	3.1	1.6	W
		T <sub>A</sub> = 70°C	3	1.0	2	1.0	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150				°C	
Soldering Recommendations (Peak Temperature) <sup>b,c</sup>		260					

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a</sup>	t ≤ 10 sec	32	40	°C/W
	Steady State	65	81	
Maximum Junction-to-Foot (Case)	Steady State	5	6.3	

#### Notes

- Surface Mounted on 1" x 1" FR4 Board.
- See Solder Profile (<http://www.vishay.com/doc?73257>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

SPECIFICATIONS (T <sub>J</sub> = 25 °C UNLESS OTHERWISE NOTED)							
Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
<b>Static</b>							
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA	P-Ch	-1.0		-3	V
		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	N-Ch	1.0		3	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25 V	P-Ch			±200	nA
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V	N-Ch			±100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -30 V, V <sub>GS</sub> = 0 V	P-Ch			-1	μA
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	N-Ch			1	
		V <sub>DS</sub> = -30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	P-Ch			-5	
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	N-Ch			5	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ -5 V, V <sub>GS</sub> = -10 V	P-Ch	-25			A
		V <sub>DS</sub> ≤ 5 V, V <sub>GS</sub> = 10 V	N-Ch	25			
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -6.4 A	P-Ch		0.041	0.051	Ω
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.7 A	N-Ch		0.028	0.035	
		V <sub>GS</sub> = -6 V, I <sub>D</sub> = -5.3 A	P-Ch		0.055	0.075	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 6.5 A	N-Ch		0.040	0.050	
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -6.4 A	P-Ch		13		S
		V <sub>DS</sub> = 15 V, I <sub>D</sub> = 7.7 A	N-Ch		15		
Diode Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>S</sub> = -1.7 A, V <sub>GS</sub> = 0 V	P-Ch		-0.80	-1.2	V
		I <sub>S</sub> = 1.7 A, V <sub>GS</sub> = 0 V	N-Ch		0.80	1.2	
<b>Dynamic<sup>b</sup></b>							
Total Gate Charge	Q <sub>g</sub>	P-Channel V <sub>DS</sub> = -15 V, V <sub>GS</sub> = -10 V, I <sub>D</sub> = -6.4 A  N-Channel V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.7 A	P-Ch		12.5	19	nC
			N-Ch		9	14	
Gate-Source Charge	Q <sub>gs</sub>		P-Ch		2.5		
			N-Ch		2		
Gate-Drain Charge	Q <sub>gd</sub>		P-Ch		3.6		
			N-Ch		1.3		
Gate Resistance	R <sub>g</sub>	P-Ch		9		Ω	
		N-Ch		3			
Turn-On Delay Time	t <sub>d(on)</sub>	P-Ch		10	15	ns	
		N-Ch		10	15		
Rise Time	t <sub>r</sub>	P-Ch		20	30		
		N-Ch		15	25		
Turn-Off Delay Time	t <sub>d(off)</sub>	P-Ch		25	40		
		N-Ch		20	30		
Fall Time	t <sub>f</sub>	P-Ch		30	45		
		N-Ch		10	15		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = -1.7 A, di/dt = 100 A/μs	P-Ch		25	50	
		I <sub>F</sub> = 1.7 A, di/dt = 100 A/μs	N-Ch		20	40	

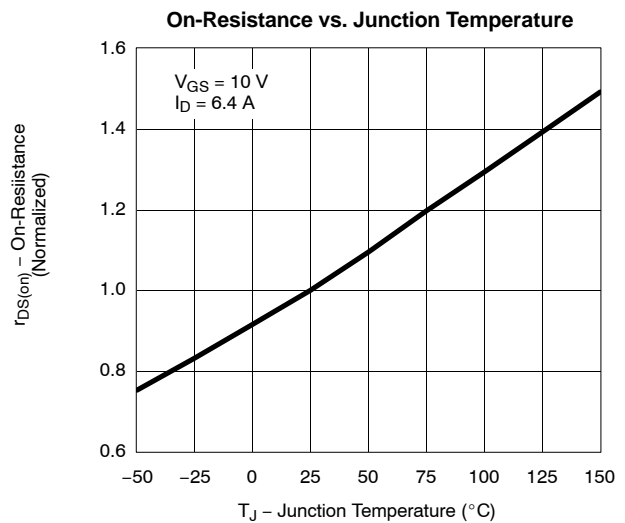
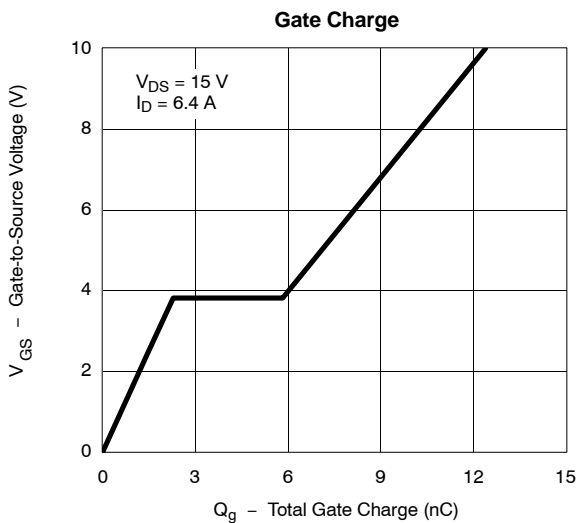
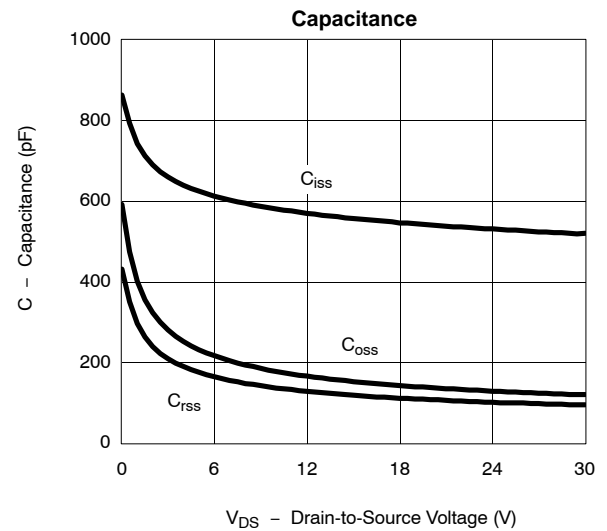
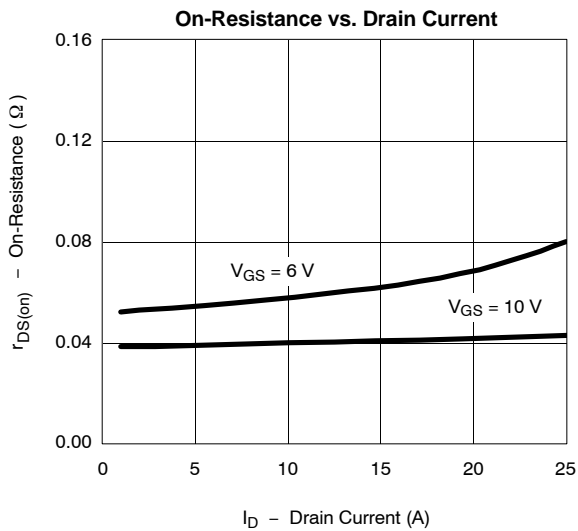
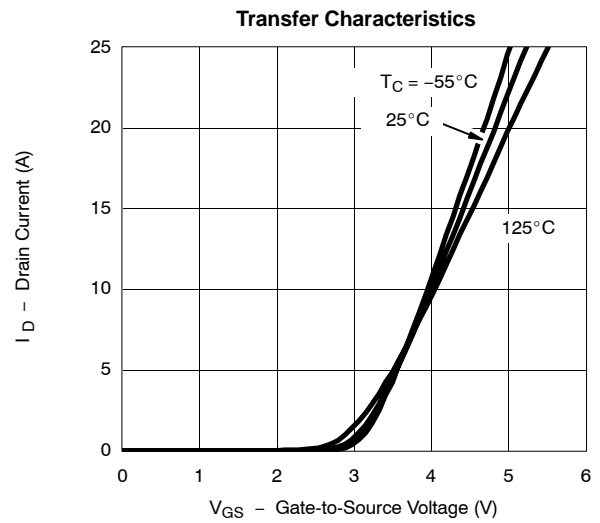
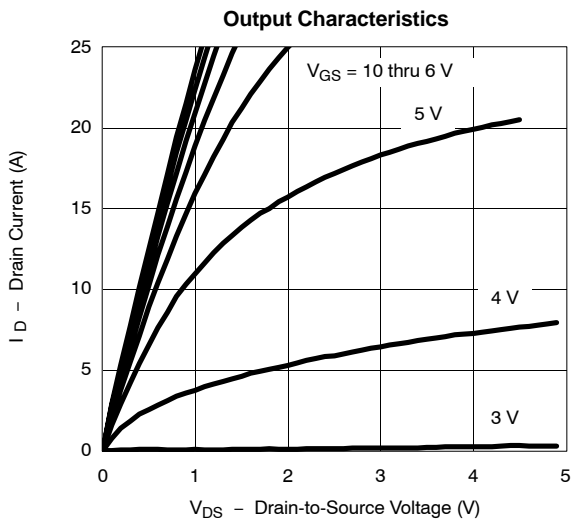
## Notes

- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%.  
 b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



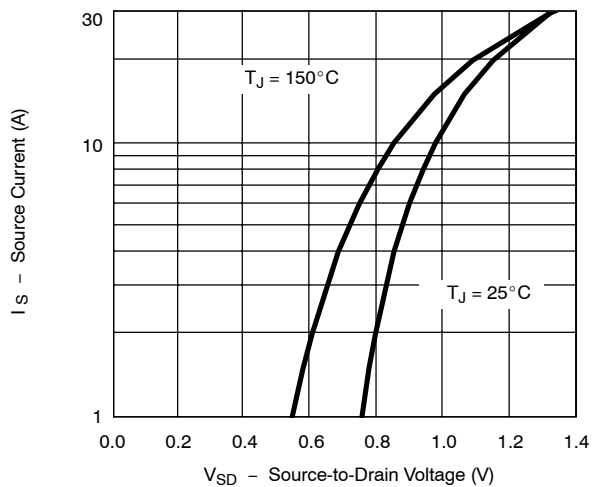
**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED) P-CHANNEL**



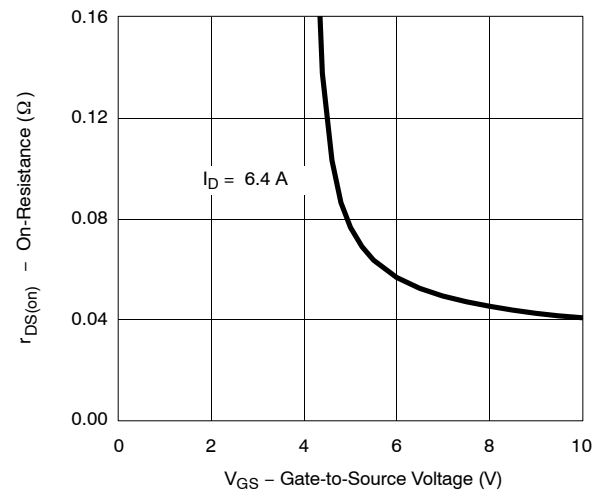
**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)**

**P-CHANNEL**

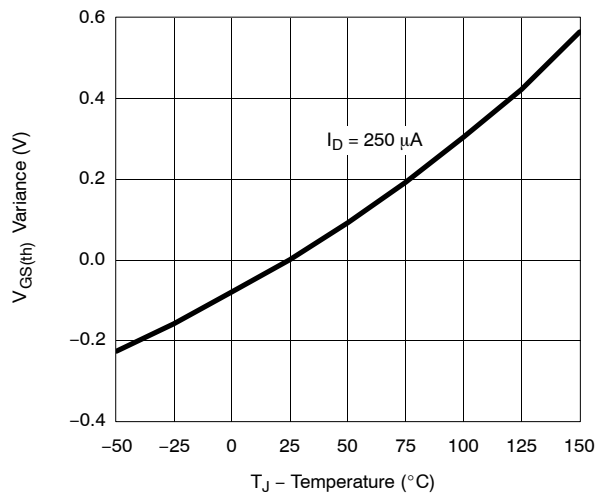
**Source-Drain Diode Forward Voltage**



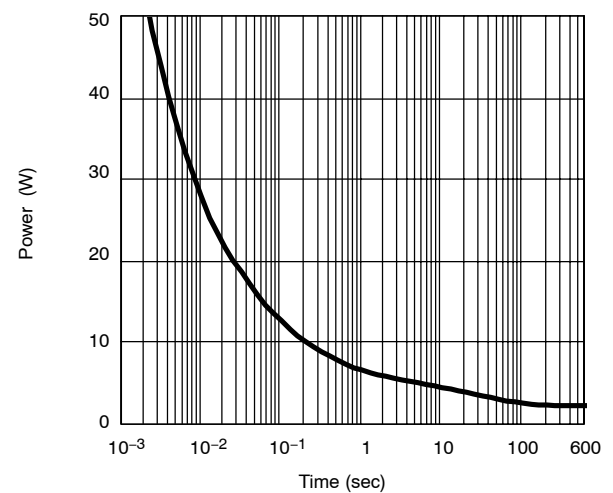
**On-Resistance vs. Gate-to-Source Voltage**



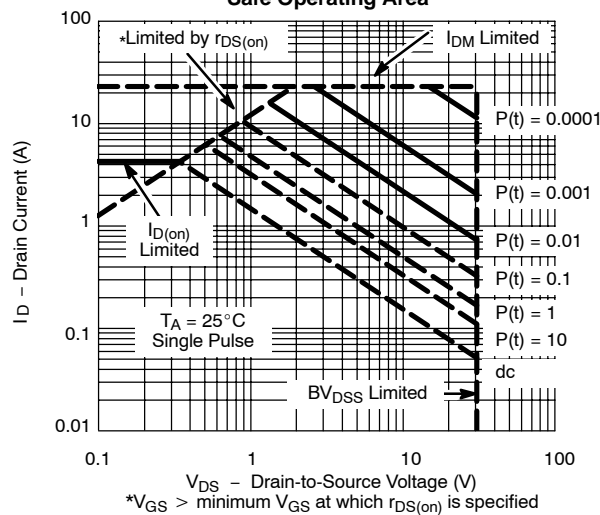
**Threshold Voltage**



**Single Pulse Power**



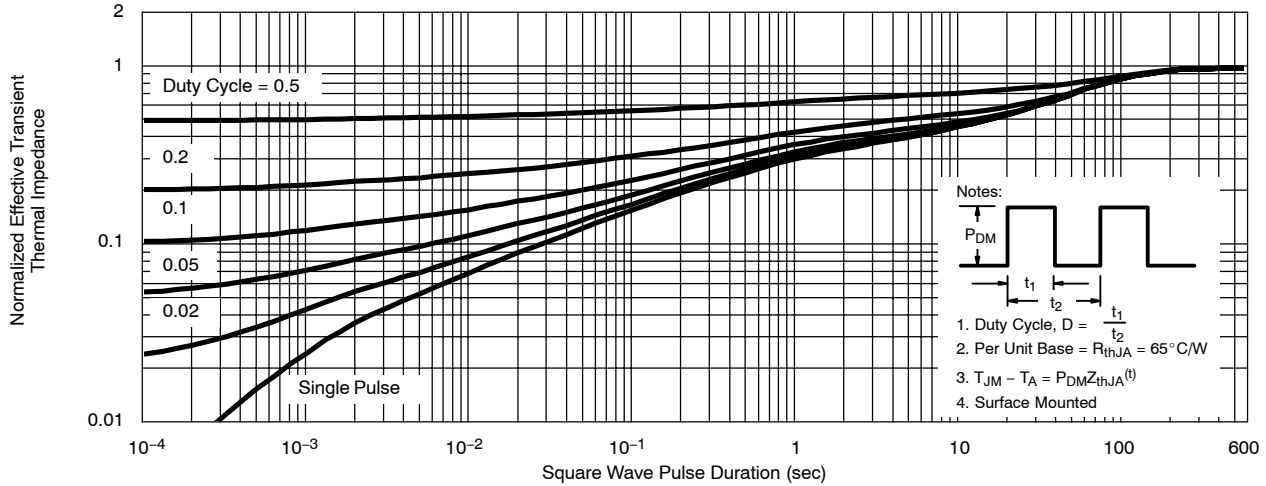
**Safe Operating Area**



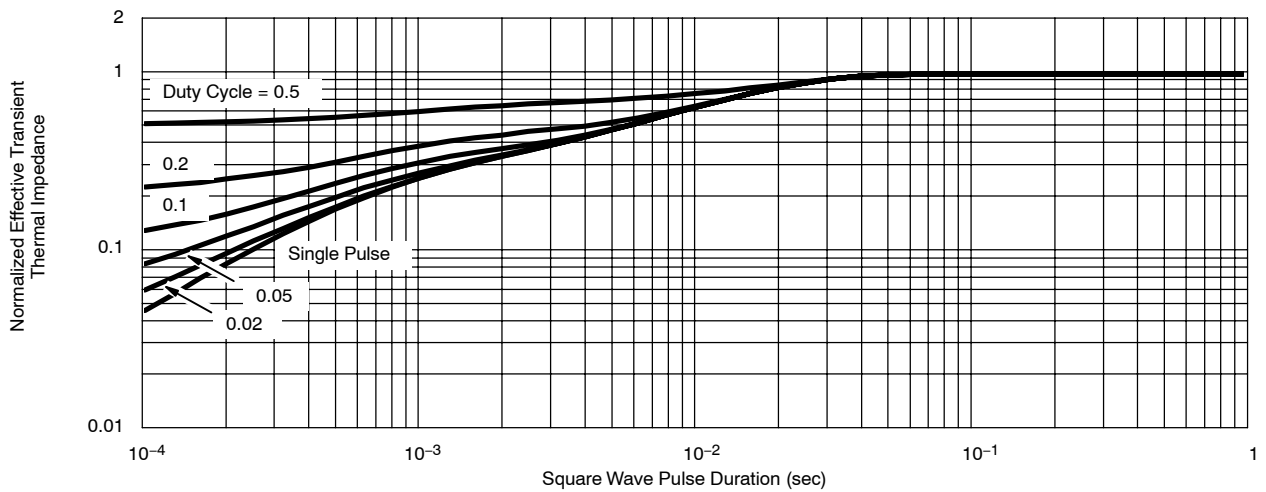


**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)** **P-CHANNEL**

Normalized Thermal Transient Impedance, Junction-to-Ambient

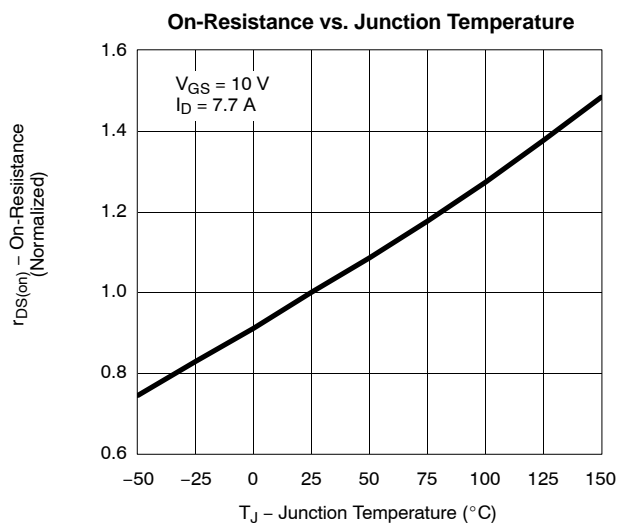
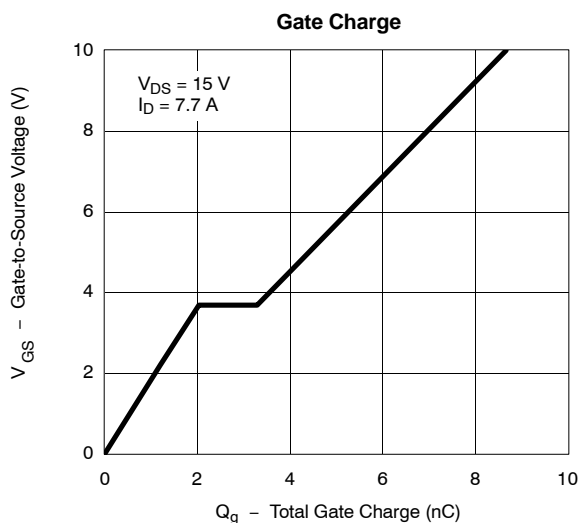
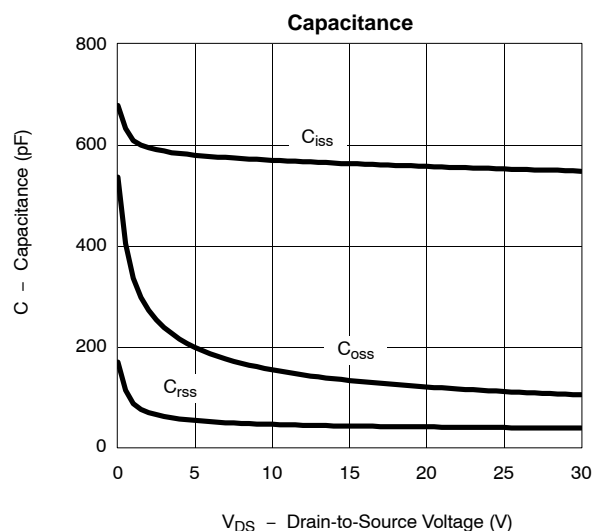
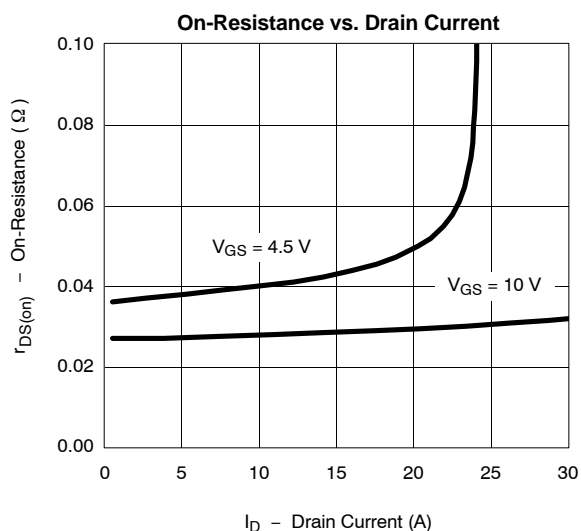
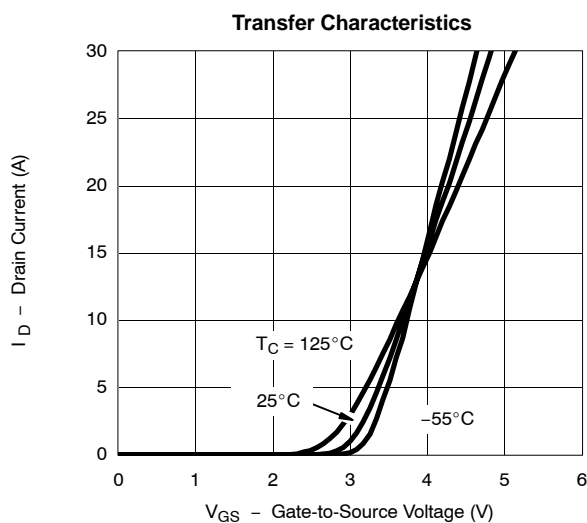
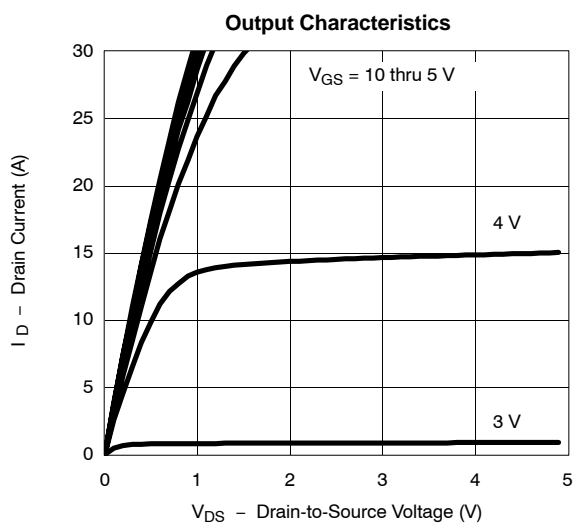


Normalized Thermal Transient Impedance, Junction-to-Case



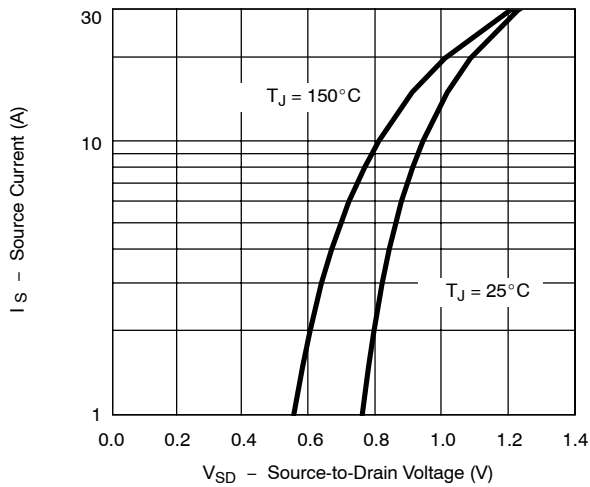
**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)**

**N-CHANNEL**

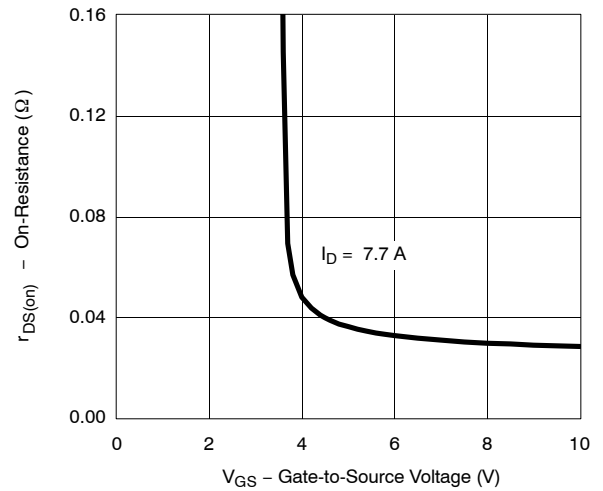


**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED) N-CHANNEL**

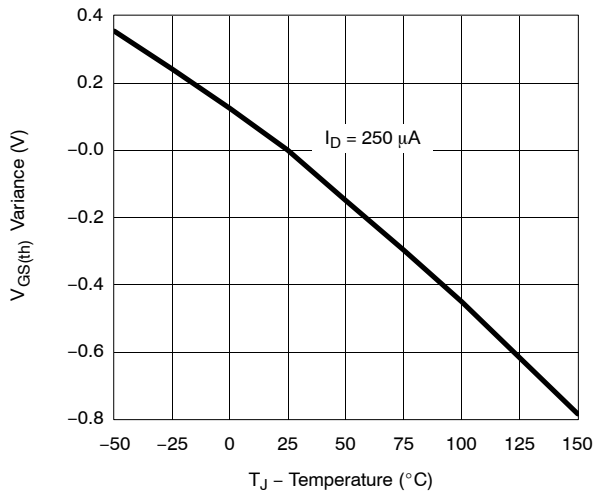
**Source-Drain Diode Forward Voltage**



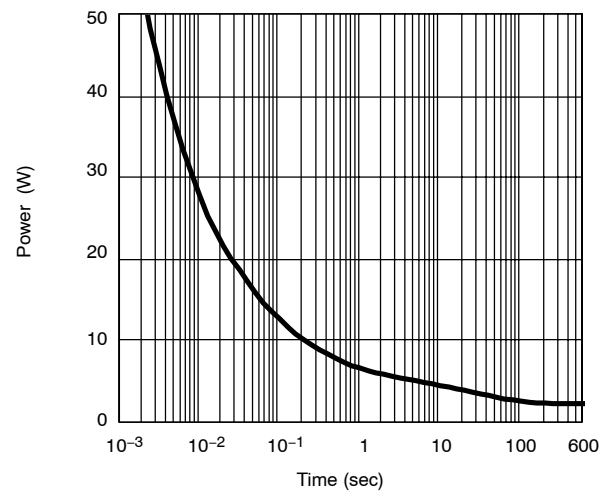
**On-Resistance vs. Gate-to-Source Voltage**



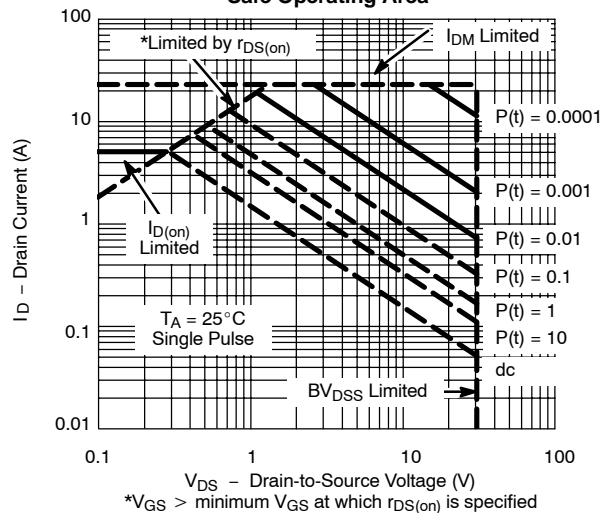
**Threshold Voltage**



**Single Pulse Power**

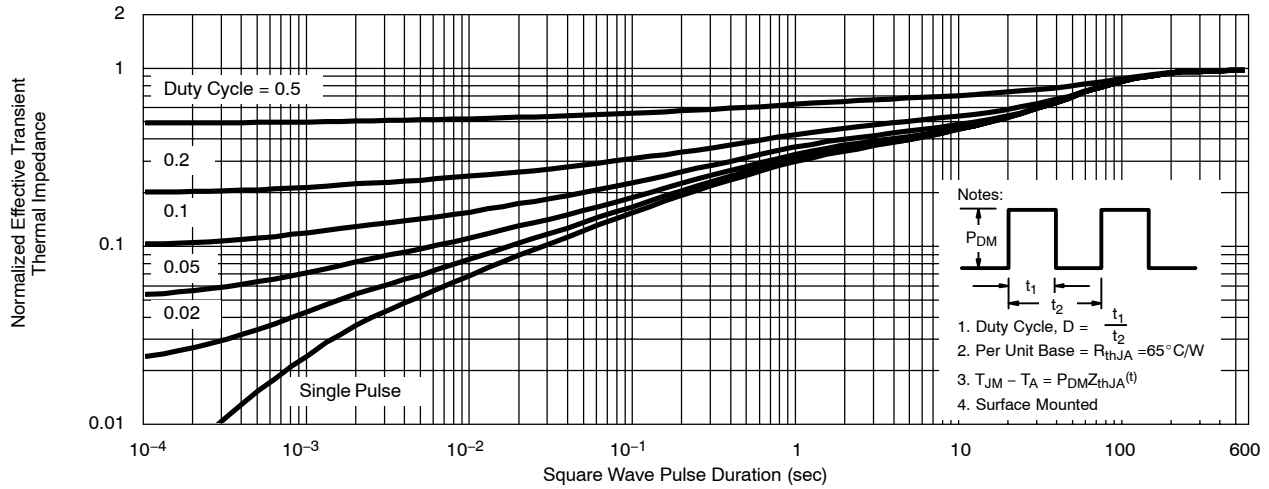


**Safe Operating Area**

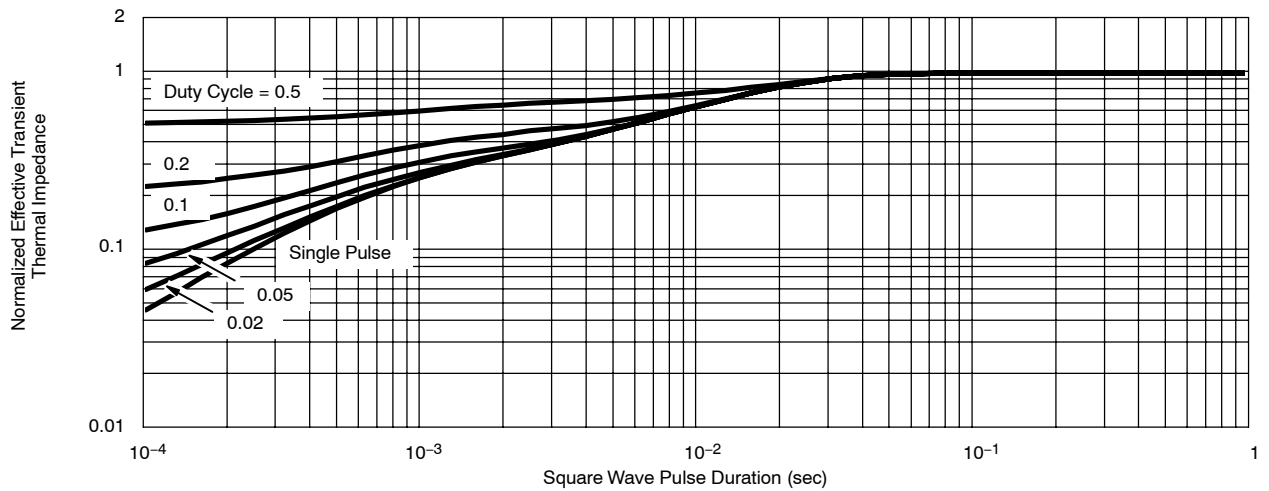


**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED) N-CHANNEL**

Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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